Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/751.469	LEE ET AL.

Examiner

Linh V. Nguyen

Art Unit 2819

	SEARCHED				
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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(INCLUDING SEARCH	DATE	EXMR
330/162,263 (Text search-see print out)	9/4/2005	LN